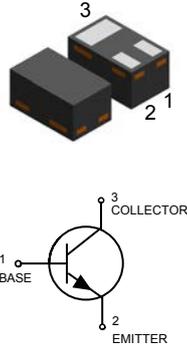


PRIMARY CHARACTERISTICS	
P_D	250mW
V_{CEO}	40V _{dc}
I_C	200mA _{dc}
$V_{CE(sat)}$	0.2V _{dc}
h_{FE}	100~300
$T_{J Max}$	150°C

SOT-883 PACKAGE
Marking Code: 1A
MARKING DIAGRAM


1A = Device Code
M = Date Code

Date Code List		
Month	Odd Year	Even Year
Jan	1	E
Feb	2	F
Mar	3	H
Apr	4	J
May	5	K
Jun	6	L
Jul	7	N
Aug	8	P
Sep	9	U
Oct	T	X
Nov	V	Y
Dec	C	Z


FEATURES

- We declare that the material of product requirements.
- Moisture Sensitivity Level 1

MECHANICAL DATA

- CASE : Molded Glass SOT-883
- POLARITY : See diagram above
- TERMINALS : Solderable per MIL-STD-750, Method 2026
- MOUNTING POSITION : Any

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V_{CEO}	40	Vdc
Collector–Base Voltage	V_{CBO}	60	Vdc
Emitter–Base Voltage	V_{EBO}	6.0	Vdc
Collector Current — Continuous	I_C	200	mAdc

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR– 5 Board, (1) $T_A = 25^\circ\text{C}$	P_D	250	mW
Derate above 25°C		2	mW/°C
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	500	°C/W
Junction and Storage Temperature	T_J, T_{stg}	–55 to +150	°C

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Collector–Emitter Breakdown Voltage(2) ($I_C = 1.0 \text{ mA}_{dc}$)	$V_{(BR)CEO}$	40	—	Vdc
Collector–Base Breakdown Voltage ($I_C = 10 \mu\text{A}_{dc}$)	$V_{(BR)CBO}$	60	—	Vdc
Emitter–Base Breakdown Voltage ($I_E = 10 \mu\text{A}_{dc}$)	$V_{(BR)EBO}$	6.0	—	Vdc
Base Cutoff Current ($V_{CE} = 30 \text{ Vdc}, V_{EB} = 3.0 \text{ Vdc},$)	I_{BL}	—	50	nAdc
Collector Cutoff Current ($V_{CE} = 30 \text{ Vdc}, V_{EB} = 3.0 \text{ Vdc}$)	I_{CEX}	—	50	nAdc

1. FR–5 = 1.0 x 0.75 x 0.062 in.

2. Pulse Test: Pulse Width <300 μs , Duty Cycle <2.0%.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted) (Continued)

Characteristic	Symbol	Min	Max	Unit
ON CHARACTERISTICS (3)				
DC Current Gain(1) ($I_C = 0.1 \text{ mAdc}$, $V_{CE} = 1.0 \text{ Vdc}$)	h_{FE}	40	—	—
($I_C = 1.0 \text{ mAdc}$, $V_{CE} = 1.0 \text{ Vdc}$)		70	—	
($I_C = 10 \text{ mAdc}$, $V_{CE} = 1.0 \text{ Vdc}$)		100	300	
($I_C = 50 \text{ mAdc}$, $V_{CE} = 1.0 \text{ Vdc}$)		60	—	
($I_C = 100 \text{ mAdc}$, $V_{CE} = 1.0 \text{ Vdc}$)		30	—	
Collector–Emitter Saturation Voltage ($I_C = 10 \text{ mAdc}$, $I_B = 1.0 \text{ mAdc}$)(3)	$V_{CE(sat)}$	—	0.2	Vdc
($I_C = 50 \text{ mAdc}$, $I_B = 5.0 \text{ mAdc}$)		—	0.3	
Base–Emitter Saturation Voltage(3) ($I_C = 10 \text{ mAdc}$, $I_B = 1.0 \text{ mAdc}$)	$V_{BE(sat)}$	0.65	0.85	Vdc
($I_C = 50 \text{ mAdc}$, $I_B = 5.0 \text{ mAdc}$)		—	0.95	

SMALL–SIGNAL CHARACTERISTICS

Current–Gain — Bandwidth Product ($I_C = 10 \text{ mAdc}$, $V_{CE} = 20 \text{ Vdc}$, $f = 100 \text{ MHz}$)	f_T	300	—	MHz
Output Capacitance ($V_{CB} = 5.0 \text{ Vdc}$, $I_E = 0$, $f = 1.0 \text{ MHz}$)	C_{obo}	—	4.0	pF
Input Capacitance ($V_{EB} = 0.5 \text{ Vdc}$, $I_C = 0$, $f = 1.0 \text{ MHz}$)	C_{ibo}	—	8.0	pF
Input Impedance ($V_{CE} = 10 \text{ Vdc}$, $I_C = 1.0 \text{ mAdc}$, $f = 1.0 \text{ kHz}$)	h_{ie}	1.0	10	k Ω
Voltage Feedback Ratio ($V_{CE} = 10 \text{ Vdc}$, $I_C = 1.0 \text{ mAdc}$, $f = 1.0 \text{ kHz}$)	h_{re}	0.5	8.0	$\times 10^{-4}$
Small–Signal Current Gain ($V_{CE} = 10 \text{ Vdc}$, $I_C = 1.0 \text{ mAdc}$, $f = 1.0 \text{ kHz}$)	h_{fe}	100	400	—
Output Admittance ($V_{CE} = 10 \text{ Vdc}$, $I_C = 1.0 \text{ mAdc}$, $f = 1.0 \text{ kHz}$)	h_{oe}	1.0	40	μmhos
Noise Figure ($V_{CE} = 5.0 \text{ Vdc}$, $I_C = 100 \mu\text{Adc}$, $R_s = 1.0 \text{ k}\Omega$, $f = 1.0 \text{ kHz}$)	NF	—	5.0	dB

SWITCHING CHARACTERISTICS

Delay Time ($V_{CC} = 3.0 \text{ Vdc}$, $V_{BE} = -0.5 \text{ Vdc}$)	t_d	—	35	ns
Rise Time ($I_C = 10 \text{ mAdc}$, $I_{B1} = 1.0 \text{ mAdc}$)	t_r	—	35	ns
Storage Time ($V_{CC} = 3.0 \text{ Vdc}$)	t_s	—	200	ns
Fall Time ($I_C = 10 \text{ mAdc}$, $I_{B1} = I_{B2} = 1.0 \text{ mAdc}$)	t_f	—	50	ns

 3. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

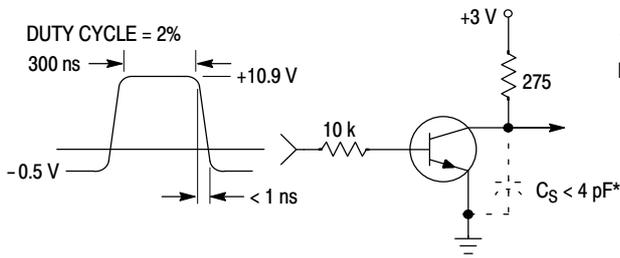


Figure 1. Delay and Rise Time Equivalent Test Circuit

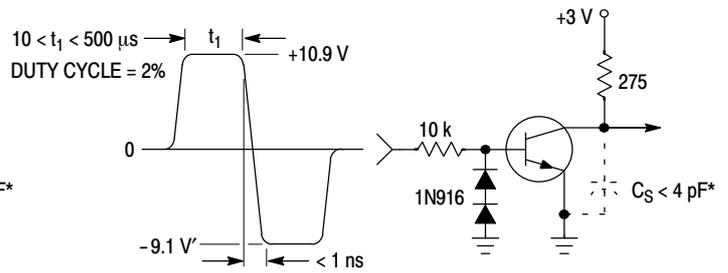


Figure 2. Storage and Fall Time Equivalent Test Circuit

* Total shunt capacitance of test jig and connectors

ELECTRICAL CHARACTERISTIC CURVES

($T_a = 25^\circ\text{C}$)

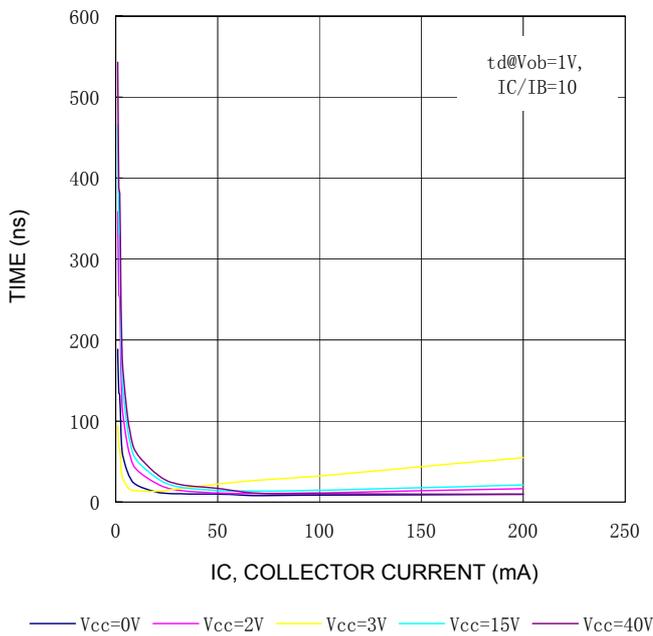


Fig.3 TURN-ON TIME

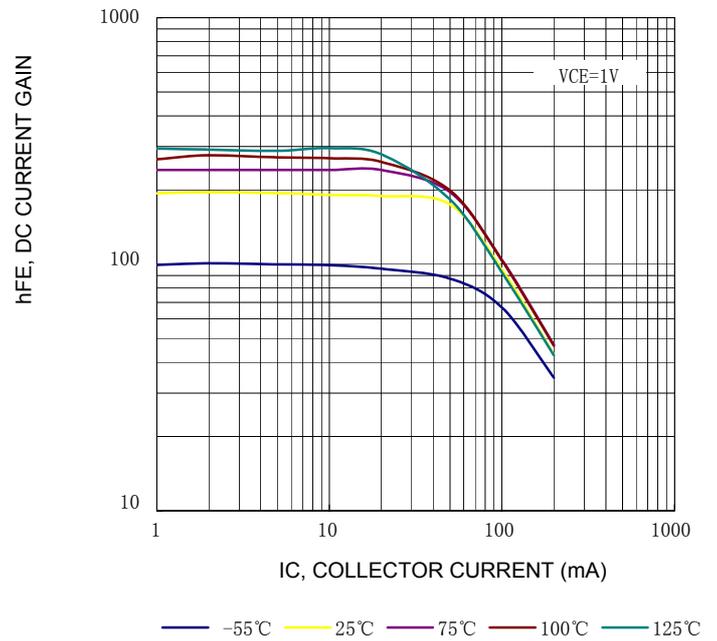


Fig.4 DC CURRENT GAIN

ELECTRICAL CHARACTERISTIC CURVES
(Ta = 25°C)

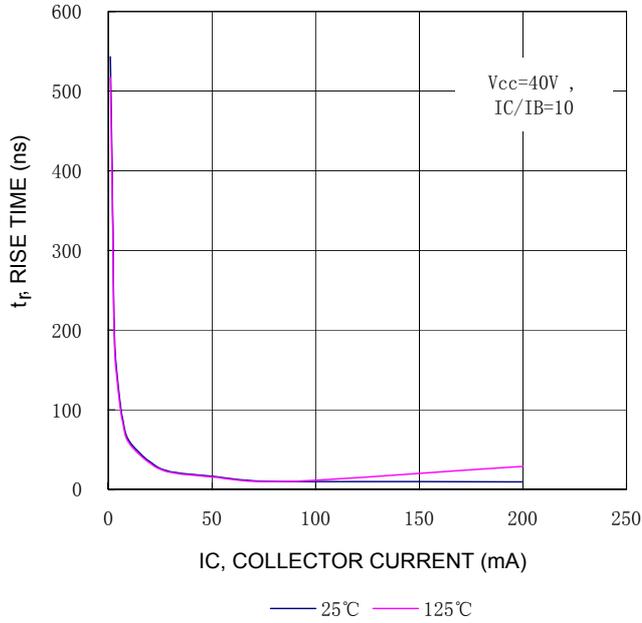


Fig.5 RISE TIME

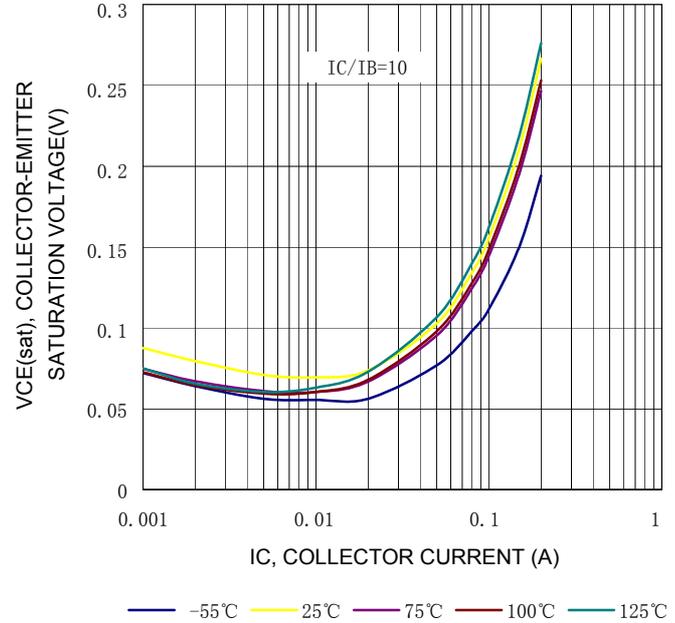


Fig.6 COLLECTOR EMITTER SATURATION VOLTAGE VS. COLLECTOR CURRENT

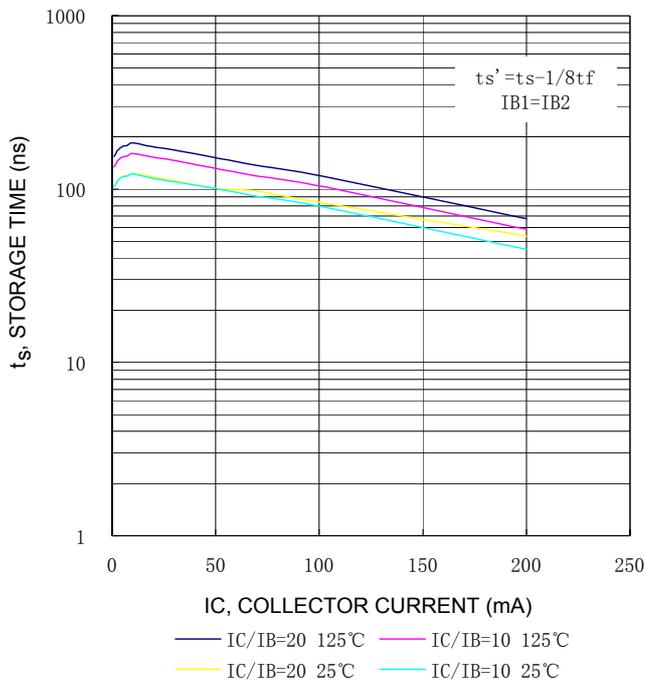


Fig.7 STORAGE TIME

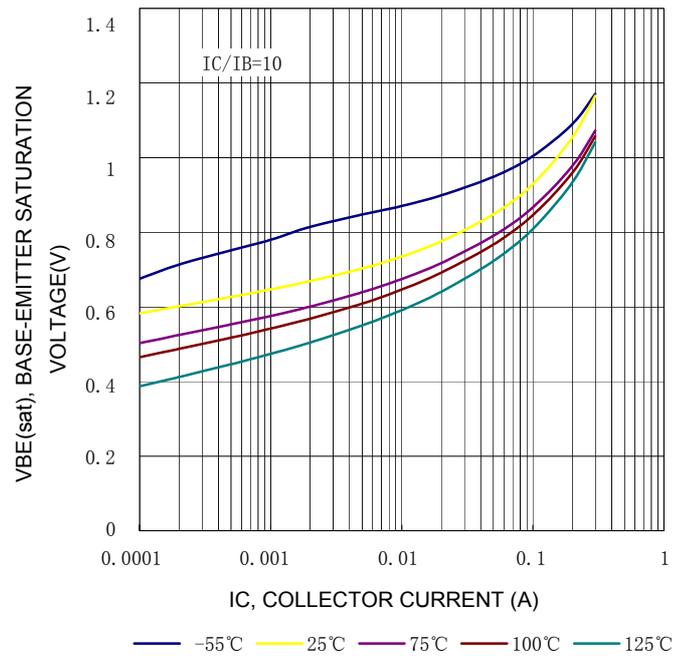


Fig.8 BASE EMITTER SATURATION VOLTAGE VS. COLLECTOR CURRENT

ELECTRICAL CHARACTERISTIC CURVES
(Ta = 25°C)

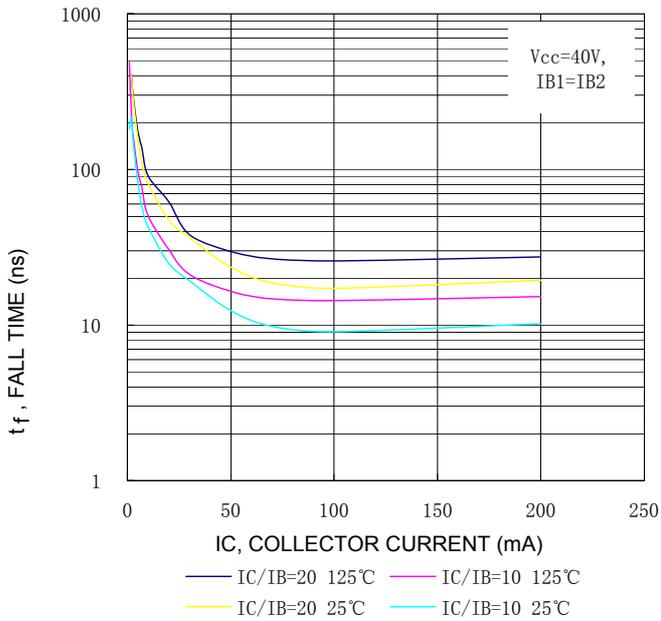


Fig.9 FALL TIME

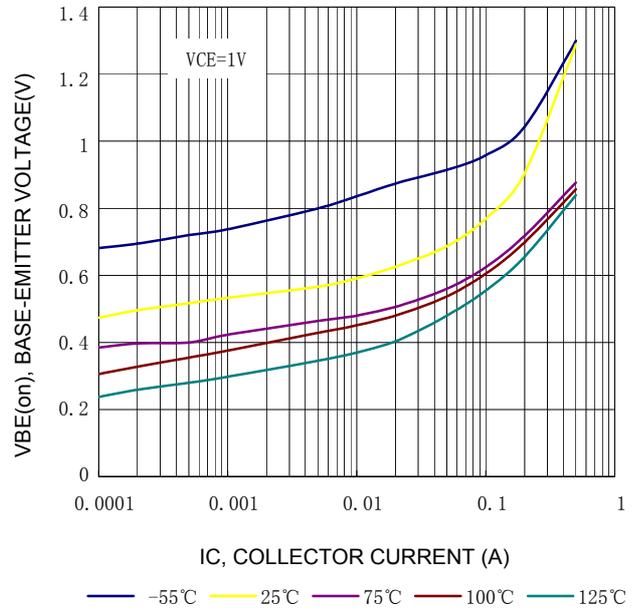


Fig.10 BASE EMITTER VOLTAGE VS. COLLECTOR CURRENT

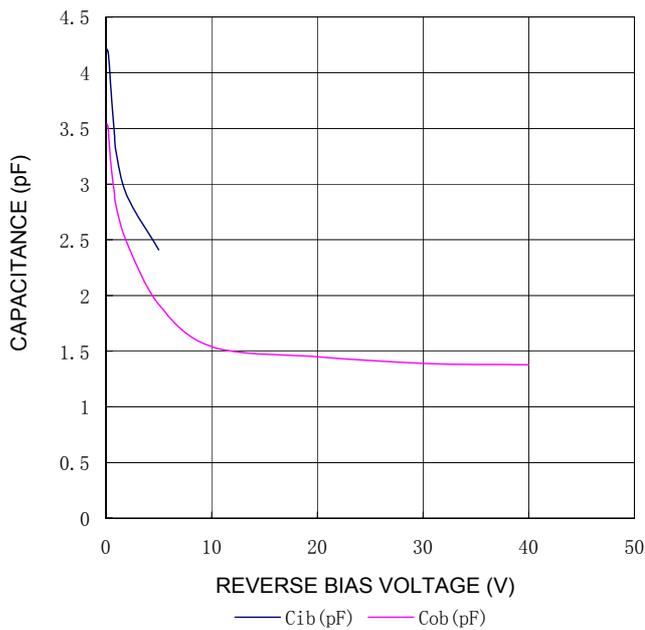


Fig.11 CAPACITANCE

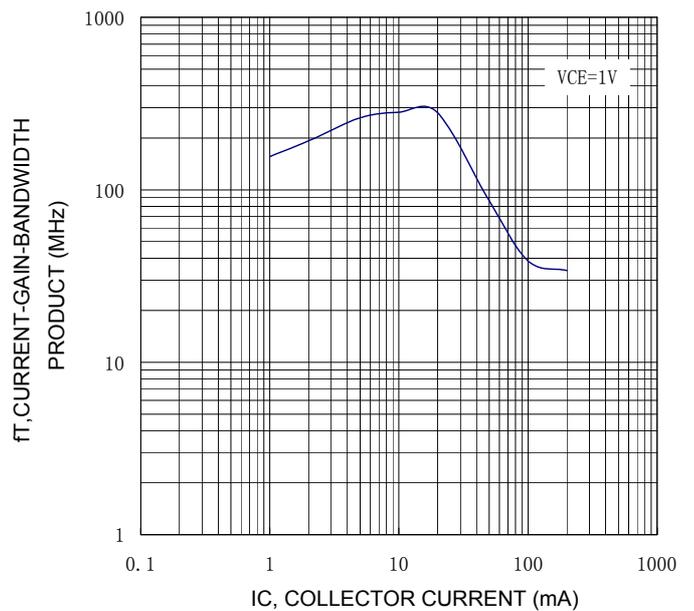


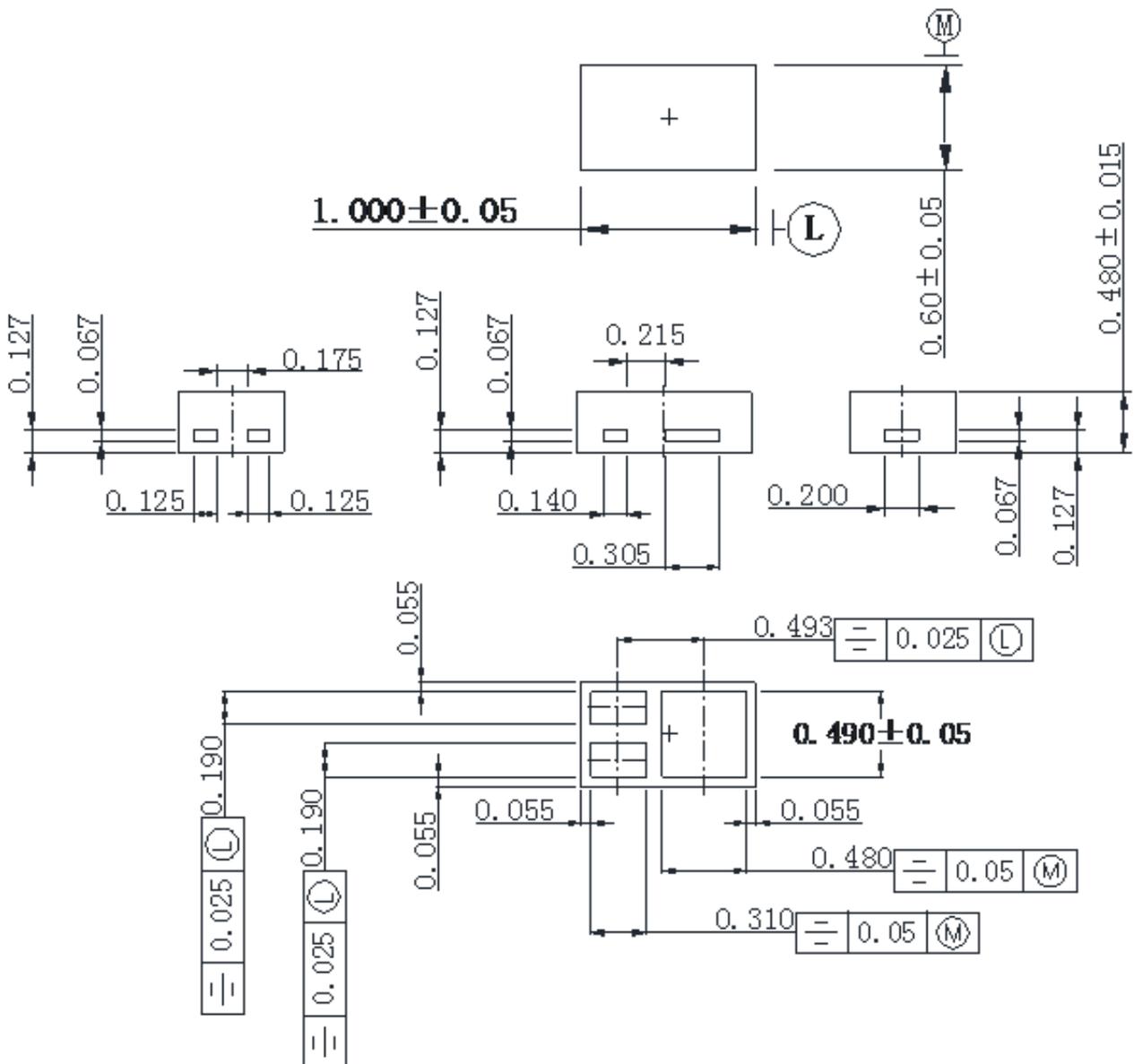
Fig.12 CURRENT GAIN BANDWIDTH PRODUCT VS. COLLECTOR CURRENT

Outline Drawing

SOT-883

DIMENSION OUTLINE:

Unit:mm



Dimensions in inches and (millimeters)

Rev.A

Ordering Information:

Device PN	Packing
UU " u V u -T ⁽¹⁾ = ⁽²⁾ -WS	Tape&Reel: Kpcs/Reel

Note: (1) Packing code, Tape & Reel Packing

(2) Halogen free product for packing code suffix "H"

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